

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/804,750	PITZ ET AL.
Examiner	Art Unit	
Tan V. Mai	2193	

Search Notes



Application/Control No.

10/804,750

Examiner

Tan V. Mai

**Applicant(s)/Patent under
Reexamination**

PITZ ET AL.

Art Unit

2193

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**